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Bayesian Inference With Muller C-Elements

Joseph S. Friedman, Member, IEEE, Laurie E. Calvet, Member, IEEE, Pierre Bessière, Jacques Droulez, and Damien Querlioz, Member, IEEE

Abstract—Bayesian inference is a powerful approach for integrating independent conflicting information for decision-making. Though an important component of robotic, biological, and other sensory-motors systems, general-purpose computers perform Bayesian inference with limited efficiency. Here we show that Bayesian inference can be efficiently performed with stochastic signals, which are particularly adapted to novel low power nanodevices that exhibit faults and device variations. A simple Muller C-element directly implements Bayes’ rule. Complex inferences are performed by C-element trees, which compute the probability of an event based on multiple independent sources of evidence. A naive Bayesian spam filter circuit is demonstrated as a pedagogical application, and design techniques for improving circuit functionality are described. Limitations of this structure are discussed in terms of signal autocorrelation. The stochastic inference structure is exceptionally robust to faults, an essential feature of decision circuits, and can therefore leverage the increased efficiency of emerging nanodevices. This hardware implementation of Bayesian inference is extremely area and power efficient, with an area-energy-delay product several orders of magnitude less than the conventional floating point implementation. These results open a pathway for a direct stochastic hardware implementation of Bayesian inference, enabling a new class of embedded decision circuits for robotics and medical applications.

Index Terms—Fault-tolerant circuit design, Muller C-element, nanotechnology, stochastic computing, variation-prone devices.

I. INTRODUCTION

BAYESIAN inference permits decision-making with maximal information integration from distinct inputs [1]. It computes the probability of an event through the incorporation of information from numerous sources. Bayesian inference has been suggested as a fundamental component of biological systems [2]–[4], and has been successfully applied to robotics and other sensory-motor systems [5].

Conventionally, Bayesian inference is performed by general-purpose processors in which the operations on probability values are executed by floating point arithmetic logic units. These systems provide high precision, but consume significant energy and area. In addition to the substantial resources required by floating point operations, conventional approaches do not make efficient use of the high parallelism of Bayesian inference [6]. Furthermore, conventional systems require exact values throughout the computation, impeding the exploitation of variation and error-prone emerging nanodevices that can compute with reduced power consumption [7]. It is therefore highly desirable to devise a specialized hardware structure to directly compute Bayesian inference that is robust to the imperfections characteristic of novel nanotechnology.

Several distinct approaches have been proposed for a specialized Bayesian hardware, including fully digital systems with dedicated architectures [8], [9], and analog computation of probabilistic inference [10], [11]. Here we propose the stochastic computation of Bayesian inference, with probabilistic signals encoded as clocked bitstreams. Stochastic computing permits complex computations with minimal hardware, but its inherent imprecision and correlations have impeded its development.

We show that stochastic Bayesian inference can be performed directly with Muller C-elements, using surprisingly simple circuits. The increase in precision with run-time inherent to stochastic computation [12], [13] is particularly well-suited to decision circuits. The C-element circuit performs useful inferences despite the imprecision and correlations of stochastic computing and process variations of scaled nanodevices [14]–[18]. Furthermore, the fault tolerant nature of stochastic computing permits the exploitation of the extreme low energy, high speed, and small size of emerging nanotechnology that can serve as low-area, low-power computing [19] and random number generation units [20], [21].

In this work, we thus leverage stochastic computing to perform Bayesian inference with a simple circuit structure. We use the spam-detection problem as an instructive example to analyze circuit performance, as it is a common application of Bayesian inference in commercial products [6]. We explore limitations to the inference circuit structure, and discuss the mitigation of these concerns. Finally, we highlight that in comparison to the conventional computation of Bayesian inference, the proposed circuit structure can achieve sufficient precision with orders-of-magnitude increases in performance and energy efficiency.

II. STOCHASTIC BITSTREAMS

Stochastic computing uses traditional logic gates in a unique manner to perform operations on clocked binary stochastic single-bit streams rather than standard multi-bit binary signals.
This allows for the compact implementation of many complex operations—for example, the product of probabilities is computed by a simple AND gate [13]. Stochastic computing is therefore an attractive alternative to CMOS for inherently probabilistic computation, and its data encoding makes it particularly effective for exploiting error-prone nanodevices.

A. Encoded Probability

In a randomly generated stochastic bitstream, the dynamics of a $0 \rightarrow 1$ ($1 \rightarrow 0$) switch can be defined by a state switching probability $a$ ($b$). The probability $R$ encoded by a stochastic bitstream is

$$ R = \frac{a}{a + b} \tag{1} $$

which, for an uncorrelated bitstream (i.e., $a + b = 1$), is equivalent to

$$ R = a. \tag{2} $$

Each bit in this bitstream thus has a probability $R$ of being “1,” and a probability $1 - R$ of being “0.” Throughout this work, the percentage of “1”s in a bitstream encodes its probability.

B. Switching Rate

A particular probability can be represented by several distinct bitstreams that all encode the same value. For example, both bitstreams “0101010101” and “0000111111” encode the value 0.5, but the second bitstream contains longer “domains” of consecutive “0”s and “1”s. This first bitstream therefore allows for an evaluation of the value with significantly fewer bits of information. For this contrived example, the value encoded by the first $N$ bits of the bitstream is closer to 0.5 for the first bitstream than the second bitstream, for any value of $N$. As will be seen in the following sections, this autocorrelation has profound implications for Bayesian inference.

It should be noted that the switching rate of a stochastic bitstream is significantly higher for signals with probabilities close to 0.5 than for extreme probabilities close to 0 or 1. For an uncorrelated stochastic bitstream with value $R$, the switching rate is given by

$$ S = 2R(1 - R) = 2a(1 - a). \tag{3} $$

C. Precision

The probabilistic nature of stochastic bitstreams implies that there is no guarantee that the bitstream encodes the precisely correct value. In a properly operating circuit, however, the probability encoded by the bitstream converges toward the correct value as its length increases. The variance of an uncorrelated stochastic bitstream of length $N$ is

$$ \text{Var} = \frac{R(1 - R)}{N}. \tag{4} $$

The expected variance of a bitstream thus decreases with $1/N$, with smaller values for extreme probabilities. The strong effect of probability $R$ on variance creates a bias that distorts the precision analysis, thereby making variance a poor metric of bitstream precision. A more appropriate metric for the error of a probabilistic signal is the Kullback-Leibler (KL) divergence

$$ KL = (1 - R) \ln \frac{1 - R}{1 - Q} + R \ln \frac{R}{Q} \tag{5} $$

which measures the information lost when a probability $Q$ is used to approximate a probability $R$. The KL divergence is designed to measure error independently of $R$ and, interestingly, the bitstream divergence approaches $1/2N$ for increasing $N$.

III. TWO-INPUT C-ELEMENT INFEERENCE

To obtain the probability of a particular event $V$, Bayesian inference incorporates the probability of $V$ given the prior $P(V)$ and evidence input $E_1$ as

$$ P(V|E_1) = \frac{P(E_1|V)P(V)}{P(E_1|V)P(V) + P(E_1|\overline{V})P(\overline{V})} \tag{6} $$

which may be rewritten

$$ P(V|E_1) = \frac{P^*(E_1)P(V)}{P^*(E_1)P(V) + (1 - P^*(E_1))(1 - P(V))} \tag{7} $$

with parameter $P^*(E_1)$ defined by

$$ P^*(E_1) = \frac{P(E_1|V)}{P(E_1|V) + P(E_1|\overline{V})}. \tag{8} $$

We now show that (7) is computed by a Muller C-element, enabling efficient inference circuits.

A. Muller C-Element

The Muller C-element, characterized by the truth table of Fig. 1(a), is a two-input memory element [22]. The output $Z$ maintains its state $Z_{prev}$ unless both inputs $X$ and $Y$ are opposite the current output state, in which case the output switches.
Substituting $P_i$ (particular, for uncorrelated bitstreams with opposite values computing, and shows that the output probability is

$$P(Z) = \frac{P(X)P(Y)}{P(X)P(Y) + (1 - P(X))(1 - P(Y))}. \quad (9)$$

Substituting $P^*(E_i)$ for $P(X)$, $P^*(V)$ for $P(Y)$, and $P(V|E_i)$ for $P(Z)$, (9) is equivalent to (7), demonstrating the Bayesian inference performed by C-elements. This equivalence motivates the implementation of Bayesian inference with stochastic computing, and shows that a simple C-element performs the complete inference of Bayes’ rule.

C. C-Element Switching

Due to the inertia inherent to C-elements, the output switches equally often or less frequently than the inputs. In contrast to a randomly generated bitstream, the switching rate of the C-element output bitstream is not uniquely determined by the probability it encodes, but is dependent on the combination of input probabilities. The upper bound of the output switching rate is the maximum switching rate of the two inputs. In particular, for uncorrelated bitstreams with opposite values ($a_i + b_i = 1$, $R_X + R_Y = 1$) and therefore equal switching rates, the expected switching rate of the output is one half of the input switching rate. Furthermore, the expected output switching rate when one input signal carries the value 0.5 is one half of the switching rate of the other input. The decreased switching causes a memory effect that results in autocorrelation - that is, the state of each bit is correlated to the states of other bits in the bitstream.

This autocorrelation causes a decrease in the amount of precision provided by a bitstream. The stochastic bitstream output of the C-element is also probabilistic and imprecise, but converges more slowly toward the precise Bayesian inference. In particular, the lower switching rate of the output, the longer the “domains” of consecutive “0”s and “1”s, and the more imprecise the bitstream. Therefore, as can be seen in the simulation results shown in Fig. 2, the error is significantly increased for extreme inputs with low switching rates. The output signals polynomially converge to the exact Bayesian inference as $N$ increases, but have consistently larger errors for opposite extreme input combinations. As these extreme opposite inputs can be considered as strong conflicting evidence, this error can be understood as inference uncertainty.

IV. MULTI-INPUT CASCaded C-ELEMENT INFERENCE

A. Cascaded C-Element Tree

The integration of additional inputs provides the capability for more complex inferences. Incorporating $E_2$ into the inference gives the probability of event $V$:

$$P(V|E_1, E_2) = \frac{P(V|E_1)P(E_2|V, E_1)}{P(V|E_1)P(E_2|V, E_1) + (1 - P(V|E_1))P(E_2|\bar{V}, E_1)}. \quad (10)$$

Under the naïve assumption that evidence inputs $E_1$ and $E_2$ are conditionally independent, $P(E_2|V, E_1) = P(E_2|V)$, and (10) reduces to

$$P(V|E_1, E_2) = \frac{P(V|E_1)P^*(E_2)}{P(V|E_1)P^*(E_2) + (1 - P(V|E_1))(1 - P^*(E_2))}. \quad (11)$$

This can in theory be computed using two cascaded C-elements, as illustrated in Fig. 3(a).
TABLE I
SAMPLE MESSAGES FOR SPAM-DETECTION

<table>
<thead>
<tr>
<th>Message</th>
<th>Message Text</th>
</tr>
</thead>
<tbody>
<tr>
<td>A</td>
<td>Do you want to get pizza for lunch?</td>
</tr>
<tr>
<td>B</td>
<td>You should check out these stochastic simulations.</td>
</tr>
<tr>
<td>C</td>
<td>If you want to earn a fortune, send a $100 check to Nigeria and we will transfer $10,000 to your account.</td>
</tr>
<tr>
<td>D</td>
<td>My commute to Nigeria includes a transfer in Morocco. I will check if my flight is on schedule if so, do you want to get pizza when I arrive?</td>
</tr>
<tr>
<td>E</td>
<td>There is a $10 fee for all check transfers.</td>
</tr>
<tr>
<td>F</td>
<td>You!</td>
</tr>
</tbody>
</table>

This inference can be extended to multiple independent evidence inputs $E_1, E_2, \ldots, E_i$ to give (12), shown at the bottom of the page. This multi-input inference can be approximated with cascaded $C$-elements [Fig. 3(b)]. The final output is expected to be

\[
P(V|\{E_1, \ldots, E_i\}) = \frac{P(V) \prod_{x=1}^{i} P^*(E_x)}{P(V) \prod_{x=1}^{i} P^*(E_x) + (1 - P(V)) \prod_{x=1}^{i} (1 - P^*(E_x))}.
\]

Straightforward arithmetic shows that the $C$-elements can equivalently be organized in trees as in Fig. 3(c).

B. Example: Bayesian Spam Filter Circuit

To illustrate the feasibility of multi-input Bayesian inference with cascaded $C$-elements, we evaluate its use for spam filtering [6], a canonical Bayesian inference. Final applications of our proposal will target situations in which decisions are automated, such as brain-machine interfaces and robotics, and for which an efficient direct hardware implementation would fuel tremendous advances.

We consider the messages in Table I: A and B are likely to be ham (i.e., not spam), C is almost definitely spam, D seems to be ham but contains many words that are associated with spam, E is probably spam, and F is entirely inconclusive. To infer the probability that a message is spam, a simple Bayesian spam filter considers the “spamicity” $P^*(W^m_x)$ of each word $W_x$ given its presence ($m_x = 1$) or absence ($m_x = 0$). Statistics are provided in Appendix A. The probability that a message is spam given the presence or absence of various keywords is computed in accordance with Section IV-A. Assuming no prior information ($P(S) = 0.5$) the posterior probability reads

\[
P(S|\{W^m_1, \ldots, W^m_i\}) = \frac{\prod_{x=1}^{i} P^*(W^m_x)}{\prod_{x=1}^{i} P^*(W^m_x) + \prod_{x=1}^{i} (1 - P^*(W^m_x))}.
\]

The three-stage $C$-element tree of Fig. 3 can be used to perform the spam filter operation on messages A-F for eight key words. The presence or absence of each word provides a particular probability that a message is spam. These $P^*(W^m_x)$ values are encoded as stochastic bitstreams and are used as inputs to the first stage of the $C$-element tree.

Simulation results for several runs of the spam filter are shown as points in the plot of Fig. 4, with the exact naive Bayesian inference shown as a solid line. This simple Bayesian system successfully filters the messages, with high outputs for message C and E, low outputs for messages A, B, and D, and an ambiguous output for F. These decisions can be reached reliably by observing bitstreams of 1000 bits. Despite the inertia and autocorrelation, these simulation results show that the inference performed by individual $C$-elements can be extended to multi-input Bayesian inference with cascaded $C$-elements.

As can be seen in the figure, there is significant variation of the output values for short bitstreams. As the bitstream length increases, the outputs converge toward values that are quite close to the exact Bayesian inference. However, the output is not perfectly exact, due to the inertia resulting from the autocorrelated domains. The largest discrepancy is for message E: the output converges to a value of 0.7, while an exact inferences gives a value of 0.78. It should further be noted that message D converges slower than other messages, which is a result of the extreme values at its input. We now discuss the origin of this non-ideal behavior.

C. Cascaded C-Element Switching & Inertia

Beyond the first stage of the tree, the inputs to $C$-elements are autocorrelated; that is, $a_i + b_i \neq 1$. More specifically, following the reasoning of Section III-C, $a_i + b_i \leq 2^{-n}$, where $n$ is the number of $C$-elements through which information has passed since the original stimulus. The $C$-elements can therefore no longer be considered as isolated black boxes, and

\[
P(V|\{E_1, \ldots, E_i\}) = \frac{P(V|\{E_1, \ldots, E_{i-1}\}) P^*(E_i)}{P(V|\{E_1, \ldots, E_{i-1}\}) P^*(E_i) + (1 - P(V|\{E_1, \ldots, E_{i-1}\})) (1 - P^*(E_i))}
\]
the autocorrelation between consecutive bits \( B^t \) and \( B^{t+1} \) of 
an output bitstream \( B \) can be described in terms of the mutual 
information \( I \) as

\[
I(B) = 1 + (1 - S) \log_2(1 - S) + S \log_2(S)
\]

for a bitstream encoding a value 0.5 with switching rate \( S \) 
defined as

\[
S = P(B^t = 1 \land B^{t+1} = 0) + P(B^t = 0 \land B^{t+1} = 1).
\]

As signals propagate through successive stages, the inertial 
nature of the C-elements induces strings of consecutive “1”s and 
“0”s. As mentioned previously, these “domains” suggest an 
increase in autocorrelation, and are therefore detrimental to the 
operation of the inference circuit. This domain growth is shown 
Fig. 5, which presents the distribution of domain sizes at each 
stage for a tree with input values of 0.5. Though the input 
bitstream domains are quite short, the domains grow as the 
signals propagate through the circuit. By the fifth stage, which 
is the result of 32 input signals, the domain distribution deviates 
from that expected for uncorrelated stochastic bitstreams, with 
the most common domain length being 17 bits.

As the output of a C-element only switches in the case of 
each half of the bitstreams have input values of 0.5. Though the input 
both inputs having values opposite that of the output, the 
the inputs encode extreme probabilities 
the inputs of the final C-element encode extreme probabilities 
and autocorrelation increases with increasing \( n \) and \( k \), as the 
signals propagated by the second-to-last stage grow larger 
domains and become more extreme. The simulations thus show 
the importance of intermediate signals in determining output 
preference for the simple cascaded C-element circuit.

D. Cascaded C-Element Precision

The importance of domain size is evident from Fig. 6, which 
shows the error for various bitstream lengths for several combi- 
nations of inputs. Similar to the case of a single C-element, the 
use of extreme probabilities leads to large domains and slow 
convergence. With cascaded gates, the intermediate signals can 
take on extreme values, resulting in massive errors for the green 
line with inputs of 0.01, 0.01, 0.99, and 0.99. The intermediate 
values are \( 10^{-4} \) and \( 10^{-14} \), preventing the representation 
of meaningful information with fewer than 10 000 bits. There 
are thus large output errors despite the expected output value 
being 0.5.

The effect of cascading on precision is studied in more depth 
in Fig. 7. Here, there is a tree structure with \( n \) stages and \( 2^n \) 
input stochastic bitstreams. The input values for one half of 
the bitstreams are \( 0.5 - k \), where \( k \) is a constant plotted on the 
\( x \)-axis. The second half of the bitstreams have input values of 
\( 0.5 + k \). This is the least favorable way to organize inputs, as 
the inputs of the final C-element encode extreme probabilities 
\( (0.5 - k)^{n-1} \) and \( (0.5 + k)^{n-1} \). Fig. 7(b) shows that the error 
and autocorrelation increases with increasing \( n \) and \( k \), as the 
signals propagated by the second-to-last stage grow larger 
domains and become more extreme. The simulations thus show 
the importance of intermediate signals in determining output 
precision, and explores the autocorrelation limitations on the 
number of inputs and their values. Therefore, when possible, 
the inputs should be organized to minimize the potential for 
inertia and extreme values at intermediate nodes in the circuit.

Because of these considerations, the behavior of cascaded C-elements deviates from that of a single C-element, and the 
output of the C-element tree can diverge from the Bayesian 
inference of (13). Despite the challenges posed by autocorre- 
cation, we have shown with the pedagogical example of spam 
fILTERING that cascaded C-elements can give useful results in 
practical situations.
Fig. 7. (a) Cascaded C-element tree circuit with \( n = 3 \) stages to evaluate worst-case input probability combination. (b) Precision (solid lines) and autocorrelation (dashed lines) of tree as a function of input values for various depths with 500,000-bit bitstreams. Error bars depict 95% confidence interval.

Fig. 8. The simulated (black dots) and expected (black line) output value for “not switching” faults. The mean KL divergence (red) is below \( 10^{-3} \) for a 99% fault rate. Error bars depict 95% confidence interval.

V. COMPUTING IMPLICATIONS

The use of stochastic computation brings exceptional fault tolerance, and the application-specific hardware enables high efficiency. This direct hardware implementation of Bayesian inference provides significant computing advantages which are particularly pronounced with error-prone nanodevices.

A. Fault Tolerance

For use with emerging nanotechnology, circuits should be designed to tolerate faults. Stochastic computation was originally designed for imprecise components, and fault tolerance is one of its primary strengths. Each incorrect bit in a stochastic bitstream causes a deviation from the correct value by only \( 1/N \), where \( N \) is the length of the bitstream. Additionally, if it is equally likely for a “0” to improperly represented by a “1” as for a “1” to be represented by a “0,” then these faults may cancel out.

1) Not Switching: For the various C-element circuits shown in Fig. 1, the most likely fault is a missed switching event due to an insufficient current being provided to overpower the latch \[28\]. This type of fault will be referred to as a “not switching” fault, and can result from the use of a low supply voltage for circuits composed of variability-prone nanodevices.

The effect of this “not switching” fault can be seen in Fig. 8, which shows the impact of fault rates up to 99%. The simulation reflects the arbitrary case of the two inputs \( X \) and \( Y \) having probability values of 0.7 and 0.1; the expected output value from (9) is 0.206. One million bits are used in this simulation.

As seen in the graph, even for extremely high error rates, the output is close to the expected value. The KL divergence remains below 0.01, which may be considered a “correct” value, as discussed in the next subsection.

The error resulting from the “not switching” fault is unbiased: the output deviates from the correct value, but is not consistently larger or smaller. This is due to the nature of the “not switching” fault: as this fault also causes incorrect values in proceeding bits and there are necessarily equal numbers of switching events from “0” to “1” as from “1” to “0,” there is an increase in domain length without biasing the output. This “not switching” fault is therefore equivalent to decreasing the bitstream length by the fault rate. Replacing the \( x \)-axis of Fig. 8 by \( 1,000,000 \times (1 - F_{\text{not switching}}) \), these results can be compared to the C-element outputs of Fig. 2. In both cases, the KL divergence rises from slightly greater than \( 10^{-6} \) to slightly greater than \( 10^{-4} \) as the bitstream length decreases from 1,000,000 to 10,000.

The exceptional tolerance of the “not switching” fault permits the consideration of advanced low-power design techniques with emerging nanotechnology. Reduction of the supply voltage provides a drastic decrease in power dissipation, but increases the likelihood of faults. Additionally, the clock speed can be increased to improve performance in exchange for an increase in faults. This fault tolerance thus provides an opportunity to optimize the power dissipation and speed for various applications and required levels of precision.

2) False Switching: If the latch itself is faulty, there is a possibility for the C-element to switch in the absence of a proper switching stimulus. This “false switching” fault is less likely than the non-switching fault. For realistic fault rates, far less than 1% in conventional circuits, the C-element structure provides the approximately correct output (KL divergence less than 0.001 for 1% fault rate). When the fault rate is increased toward 100%, the output approaches a random bitstream with probability 0.5. This can be understood as the expected result of the output switching every clock cycle—both those in which it is expected to switch, and those in which no switching event is expected. While this is not a realistic concern, this bias toward 0.5 can be interpreted in the context of a decision-making
process as uncertainty arising from unreliable nanoelectronic components.

B. Inference Efficiency

This C-element Bayesian inference structure uses a simple circuit to stochastically compute inferences. The precision increases as more bits are used for the inference, at the cost of increased energy and delay. In comparison to conventional implementations with floating point operations, the C-element inference structure provides significant improvements in area, performance, and energy consumption. However, when performing benchmark tests, the “correctness” of a Bayesian inference is application-specific. Here, a KL divergence of less than 0.01 is considered “correct” for an unspecified general circuit. Using (5), this divergence corresponds to a value of 0.5 being approximated as 0.57, a value of 0.1 being approximated as 0.15, and a value of 0.01 being approximated as 0.03. Clearly, more precision is necessary for some applications; for others, less precision is necessary.

To perform a comparison, the circuit efficiency is evaluated under identical technology node and process. Standard cells from Synopsys’ SAED_EDK90_CORE library are used [29]; the efficiency of each component is considered at its ideal operating conditions. For the C-element, the circuit of Fig. 1(d) is chosen despite its non-ideality, as it can most easily be translated to standard cells. For the conventional floating point units, the parameters are optimized for the SAED_EDK90_CORE library by Tziantzioulis et al. [30]. These parameters are described in Appendix B.

1) Area: For a two-input Bayesian inference, this stochastic circuit requires just one C-element. This is in contrast to the conventional floating point implementation, which requires addition, multiplication, and division units. With the standard cells described above, the floating point circuit consumes \(\sim 16000\) times more area than a C-element. This estimate ignores the overhead associated with random number generation, which may be efficiently achieved with emerging nanodevices [16], [20], [21] and will therefore become essential elements of stochastic computers.

For multi-input Bayesian inference, a single floating point circuit can be used. The stochastic C-element inference structure, however, requires \(T-1\) C-elements, where \(T\) is the number of inputs. Therefore, the C-element provides an area reduction of \(\sim 5400x\) for a two-stage (four-input) inference and \(\sim 2300x\) for a three-stage (eight-input) inference. Similar calculations can be performed for inferences with additional inputs.

2) Performance: Whereas the stochastic C-element inference structure provides increasing precision with increasing time, the floating point implementation provides a highly-precise inference after its characteristic latency period. Therefore, the performance benefit provided by the C-element structure is dependent on the necessary precision for the specific application.

For multi-input Bayesian inference, the multi-stage C-element circuit needs only one additional cycle per stage to compute a bitstream with a particular length. However, the autocorrelation and domain growth contribute to a loss of precision, requiring longer bitstreams and slightly more computation time to achieve a precise output. The floating point circuit, by contrast, performs multiple pipelined computations and computes a highly precise output after its characteristic delay time. These processes are compared in Fig. 9, which considers a tree with \(n\) stages and \(2^n\) input bitstreams all encoding the probability 0.5. As can be seen in the figure, the times required to achieve a KL divergence of 0.01 are of the same order of magnitude.

3) Energy Consumption: The C-element inference circuits consume a static energy proportional to the bitstream length in addition to a dynamic energy related to the switching rate, with the dynamic energy consumption largely dominant under typical conditions. Therefore, the energy required for a C-element to output a given value with a particular level of precision is nearly independent of input probability values. For extreme inputs, a large number of bits is required, but the effect is counteracted by the low switching rate. In comparison to the floating point implementation, there is an enormous reduction in the energy required to produce a KL divergence of 0.01, of roughly three orders of magnitude.

The multi-input C-element inference provides similarly large reductions in energy consumption compared to the floating point implementation. As shown in Fig. 10, the energy consumption of both approaches increases with an increasing
number of stages. These results show a ∼1000x reduction in energy consumption to produce an output with a KL divergence of 0.01.

VI. CONCLUSION

This work highlights the ability to perform Bayesian inference with simple circuits that can exploit emerging nanotechnology. In a stochastic approach, a circuit composed of Muller C-elements can integrate conflicting evidence from independent sources to provide an increasingly precise approximation of the probability of an event. Although extensions that provide a more formal analysis of the autocorrelation and explore inertia mitigation through signal rerandomization are envisioned, the C-element inference structure introduced here already achieves sufficient accuracy for some practical applications, and validates the basic concept of using stochastic computing to perform Bayesian inference.

The efficiency and fault tolerance of the C-element inference circuit provides significant advantages over conventional software implementations using floating point hardware. As shown in Fig. 11, the area-energy-delay product (AEDP) for producing a KL divergence of 0.01 is roughly one billionth of the floating point hardware implementations using floating point hardware. As shown in Table II, eight key words are chosen and used for evaluating the messages. For each word, Laplace’s rule of succession is applied to correctly handle incomplete observation:

\[
P \left( W_x^1 | S \right) = \frac{1 + \#\text{SpamWith}W_x^1}{2 + \text{#Spams}}
\]

\[
P \left( W_x^1 | H \right) = \frac{1 + \#\text{HamWith}W_x^1}{2 + \text{#Hams}}.
\]

The spamicity is calculated in accordance with Bayes’ rule:

\[
P \left( S | W_x^1 \right) = \frac{P(S)P \left( W_x^1 | S \right)}{P(S)P \left( W_x^1 | S \right) + P(H)P \left( W_x^1 | H \right)}.
\]

Assuming that \(P(S) = P(H)\) gives

\[
P^* \left( W_x^1 \right) = \frac{P \left( W_x^1 | S \right)}{P \left( W_x^1 | S \right) + P \left( W_x^1 | H \right)}.
\]

The probability that a message is spam given the absence of a particular key word is calculated similarly:

\[
P^* \left( W_x^0 \right) = \frac{P \left( W_x^0 | S \right)}{P \left( W_x^0 | S \right) + P \left( W_x^0 | H \right)}.
\]

The areas of the various circuits are listed in Table III. The circuit design has one hardware implementation for each function, and the results are pipelined when a particular function is used on multiple occasions. Whereas the area of the

APPENDIX A

BAYESIAN SPAM FILTER

A naïve Bayesian spam filter searches a message for particular key words and computes the probability of the supposition that the message is spam based on their presence or absence. As shown in Table II, eight key words are chosen and used for evaluating the messages. For each word, Laplace’s rule of succession is applied to correctly handle incomplete observation:

\[
P \left( W_x^1 | S \right) = \frac{1 + \#\text{SpamWith}W_x}{2 + \text{#Spams}}
\]

\[
P \left( W_x^1 | H \right) = \frac{1 + \#\text{HamWith}W_x^1}{2 + \text{#Hams}}.
\]

The spamicity is calculated in accordance with Bayes’ rule:

\[
P \left( S | W_x^1 \right) = \frac{P(S)P \left( W_x^1 | S \right)}{P(S)P \left( W_x^1 | S \right) + P(H)P \left( W_x^1 | H \right)}.
\]

Assuming that \(P(S) = P(H)\) gives

\[
P^* \left( W_x^1 \right) = \frac{P \left( W_x^1 | S \right)}{P \left( W_x^1 | S \right) + P \left( W_x^1 | H \right)}.
\]

The probability that a message is spam given the absence of a particular key word is calculated similarly:

\[
P^* \left( W_x^0 \right) = \frac{P \left( W_x^0 | S \right)}{P \left( W_x^0 | S \right) + P \left( W_x^0 | H \right)}.
\]

The probability that a message is spam given the presence or absence of the various key words is calculated according to (14). For the case of message D, the equation is

\[
P(S|\text{Message } D) = P \left( S \mid \text{Nigeria}^1, \text{Pizza}^1, \text{Stochastic}^0, \text{Check}^1, \text{You}^1, \text{Transfer}^1, \text{Commute}^1, \text{Fortune}^0 \right).
\]
convventional inference circuit is independent of the number of inputs to the inference, the C-element approach requires $2^{n−1}$ C-elements for an inference circuit with $n$ stages.

### B. Performance Comparison

The delays of the various circuits are listed in Table IV. For the conventional approach, ideal pipelining is assumed in which the operations are pipelined with a spacing equivalent to the number of issue cycles; there is therefore a decrease in delay per inference when more than one stage is combined for a cascaded circuit. These delay figures apply under the assumption that the separate hardware units of the floating point inference circuit each operate at their own ideal clock frequency. These assumptions are likely to underestimate the delay of the conventional inference.

### C. Energy Consumption Comparison

The energy consumptions of the various circuits are listed in Table V. For the C-element, the expected energy consumed per bit is given for the worst case, with input values of 0.5. It is assumed that switching energy (but not power) is independent of frequency. For the conventional approach, it is assumed that the circuit dissipates static power throughout the complete inference calculation. In lieu of an accurate evaluation of the activity rate of the various circuit components, it is assumed that each cell of each arithmetic circuit switches once per arithmetic operation. These assumptions are likely to underestimate the energy consumption of the conventional inference.

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